Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/713,808	HOON ET AL.	
Examiner	Art Unit	
Sean E. Aeder	1642	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOT (INCLUDING SEARCH		")
•	DATE	EXMR
STN (MEDLINE, BIOSIS, EMBASE, SCISEARCH, DISSABS; attached), MEDLINE, WEST (PGPB, USPT, USOC, EPAB, JPAB, DWPI; attached)	9/7/2007	SEA
PALM inventor search	9/7/2007	SEA
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